



Special Module on Intelligent Information Processing

**Dayalbagh Educational Institute
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CSM 802

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SIV 895



What is Machine Learning

“Learning is any process by which a system improves performance from experience.” Herbert Simon

Definition by Tom Mitchell (1998):

Machine Learning is the study of algorithms that

- improve their performance P
- at some task T
- with experience E .

A well-defined learning task is given by $\langle P, T, E \rangle$.



What is Machine Learning

“Machine Learning: Field of study that gives computers the ability to learn without being explicitly programmed.” - Arthur Samuel (1959)





What is Machine Learning

Traditional Programming



Machine Learning



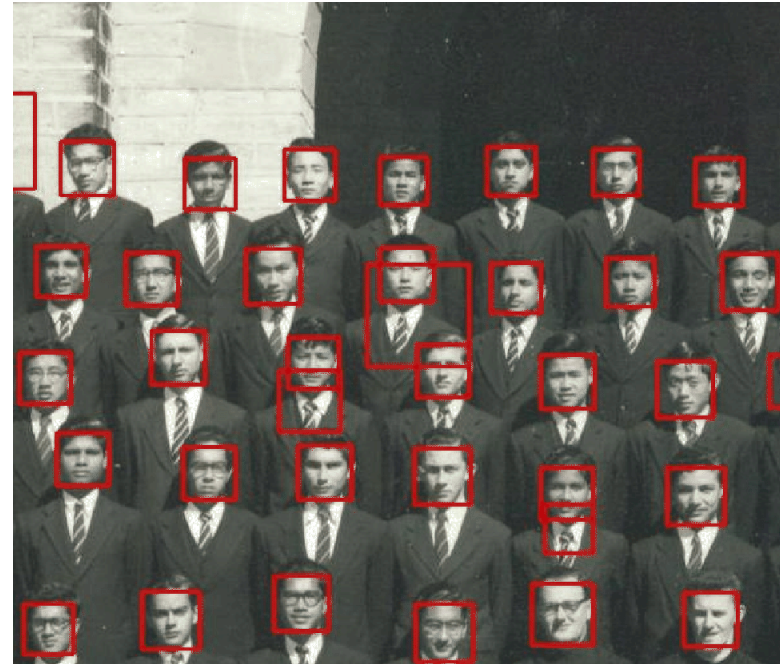


Where is it used

- Recognizing patterns:
 - Facial identities or facial expressions
 - Handwritten or spoken words
 - Medical images
- Generating patterns:
 - Generating images or motion sequences
- Recognizing anomalies:
 - Unusual credit card transactions
 - Unusual patterns of sensor readings in a nuclear power plant
- Prediction:
 - Future stock prices or currency exchange rates



Face Detection/Recognition





Facial Expression Recognition

Anger



Fear



Disgust



Surprise



Happiness



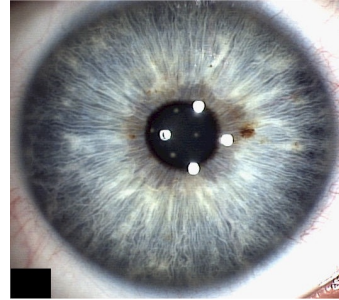
Sadness



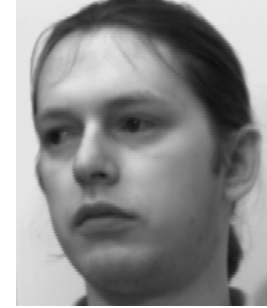
Object Identification/Recognition



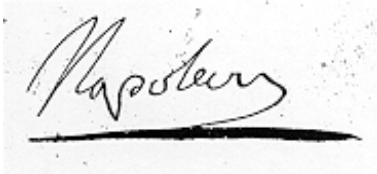
Fingerprint



Iris



Face





Autonomous/Assisted Cars



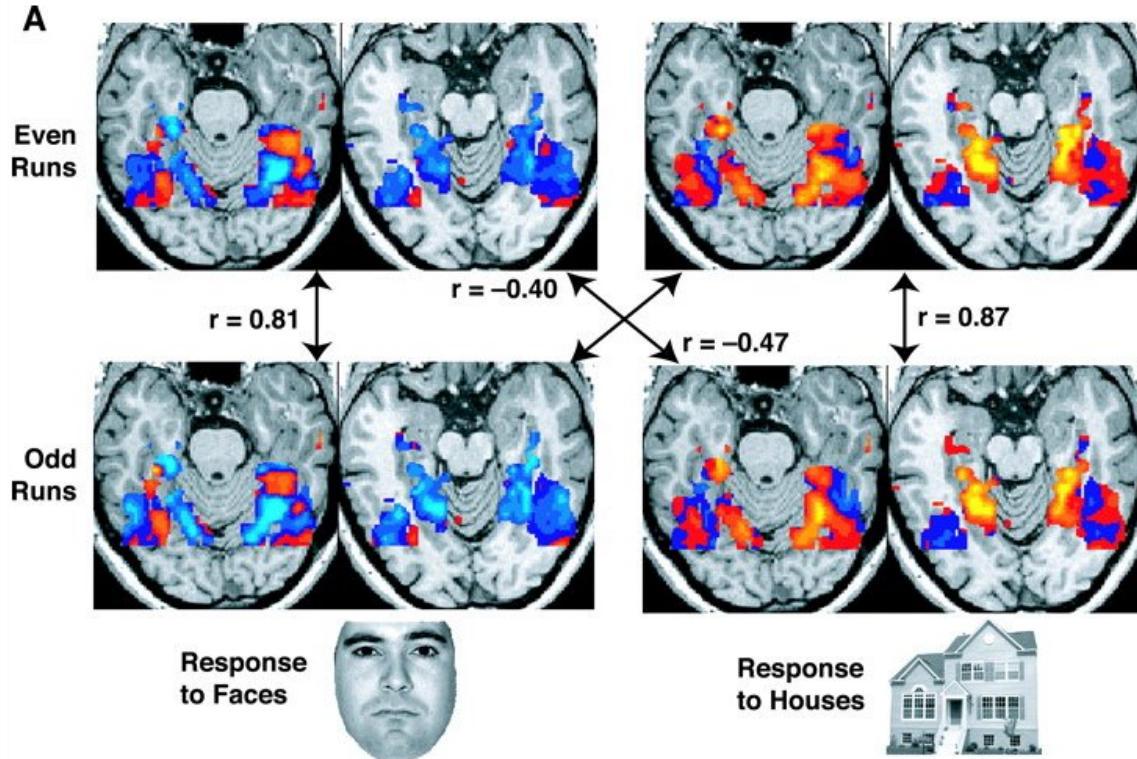
Sensing the Driving Scene



Note the vast amount of information the system can provide – free space (green carpet), vehicle and pedestrian detection, traffic sign recognition, lane markings – for the vehicle to understand and negotiate the driving scene.



Medical Images





How are things learnt

■ Memorization

- Accumulation of individual facts
- Limited by
 - Time to observe facts
 - Memory to store facts

Declarative knowledge

■ Generalization

- Deduce new facts from old facts
- Limited by accuracy of deduction process
 - Essentially a predictive activity
 - Assumes that the past predicts the future

Imperative knowledge

- Interested in extending to programs that can infer useful information from **implicit** patterns in data



Basic Paradigm

Observe set of examples: training set

Infer something about process that generated that data

Use inference to make predictions about previously unseen data: test set

Types of learning:

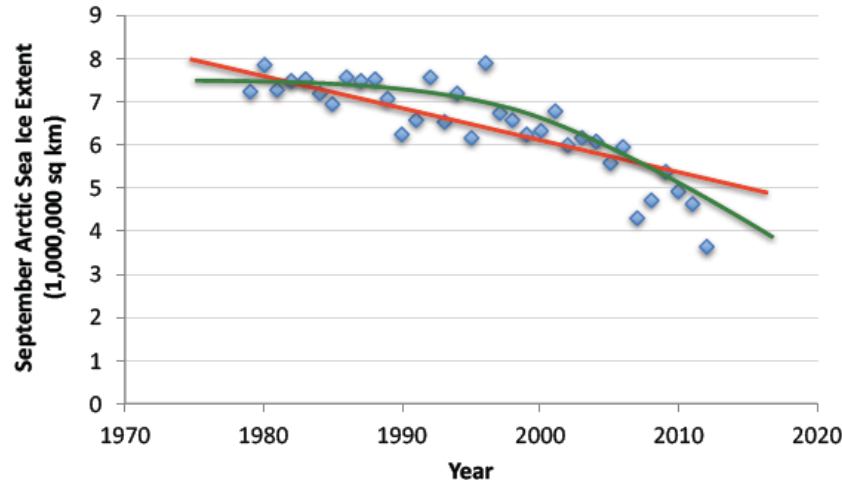
Supervised: given a set of features/label pairs, find a rule that predicts the label association with unseen data

Unsupervised: given a set of feature vectors (without labels), find natural groups or clusters (create labels for groups)



Supervised Learning: Regression

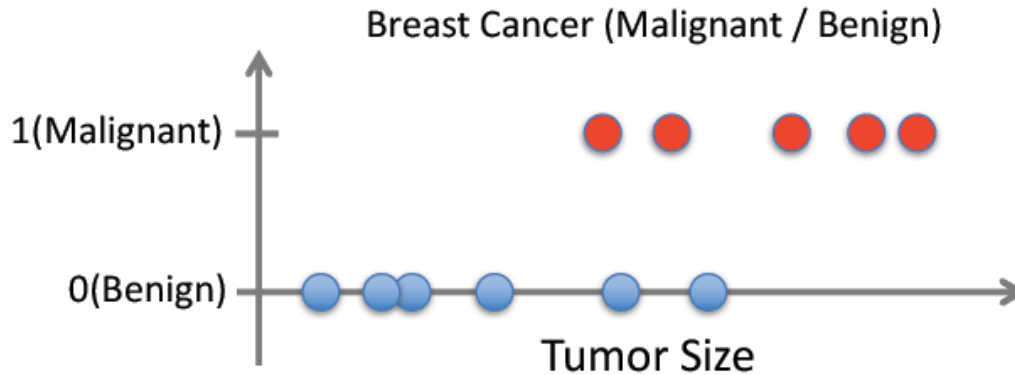
- Given $(x_1, y_1), (x_2, y_2), \dots, (x_n, y_n)$
- Learn a function $f(x)$ to predict y given x
 - y is real-valued == regression





Supervised Learning: Classification

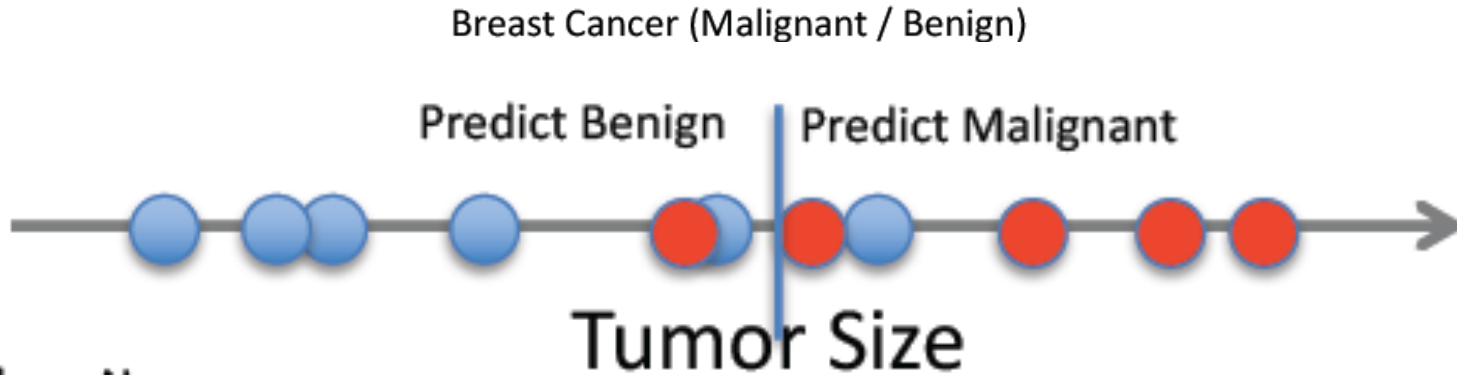
- Given $(x_1, y_1), (x_2, y_2), \dots, (x_n, y_n)$
- Learn a function $f(x)$ to predict y given x
 - y is categorical == classification





Supervised Learning: Classification

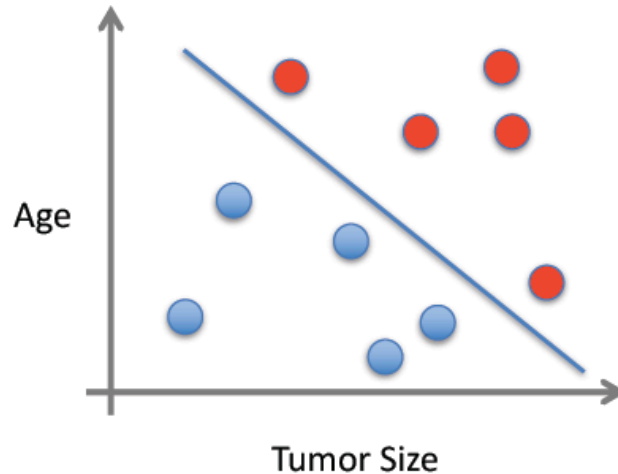
- Given $(x_1, y_1), (x_2, y_2), \dots, (x_n, y_n)$
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Supervised Learning: Classification

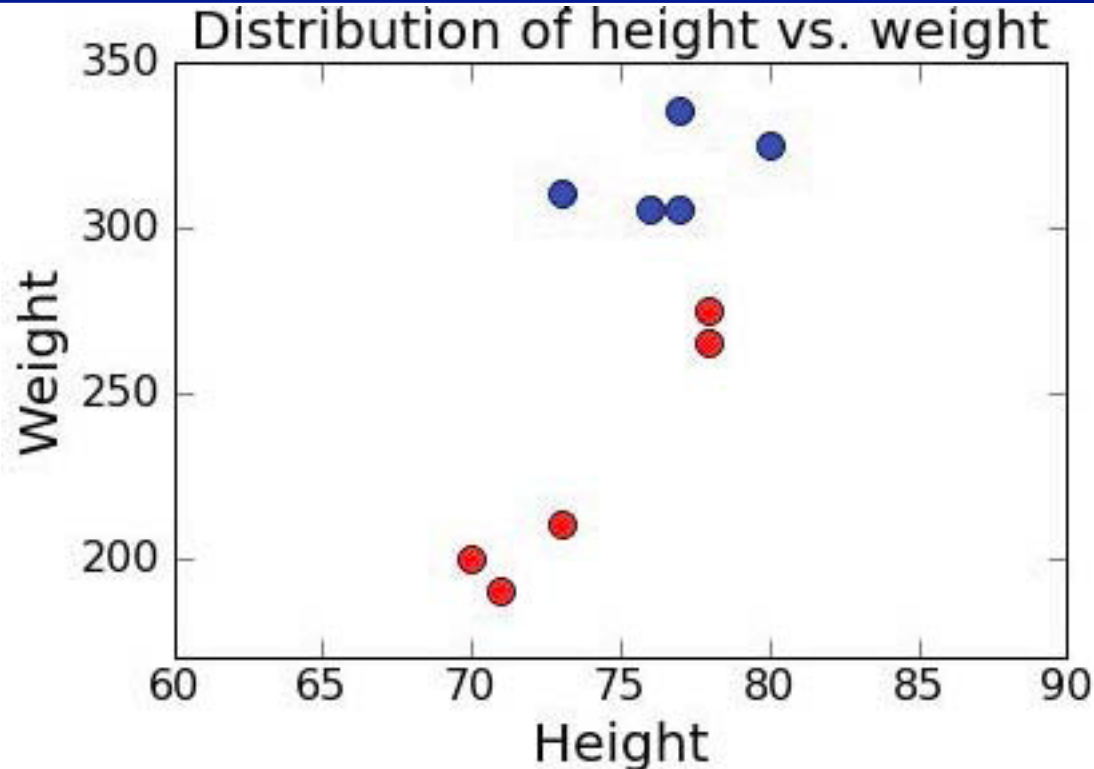
- x can be multi-dimensional
 - Each dimension corresponds to an attribute



- Clump Thickness
- Uniformity of Cell Size
- Uniformity of Cell Shape
- ...



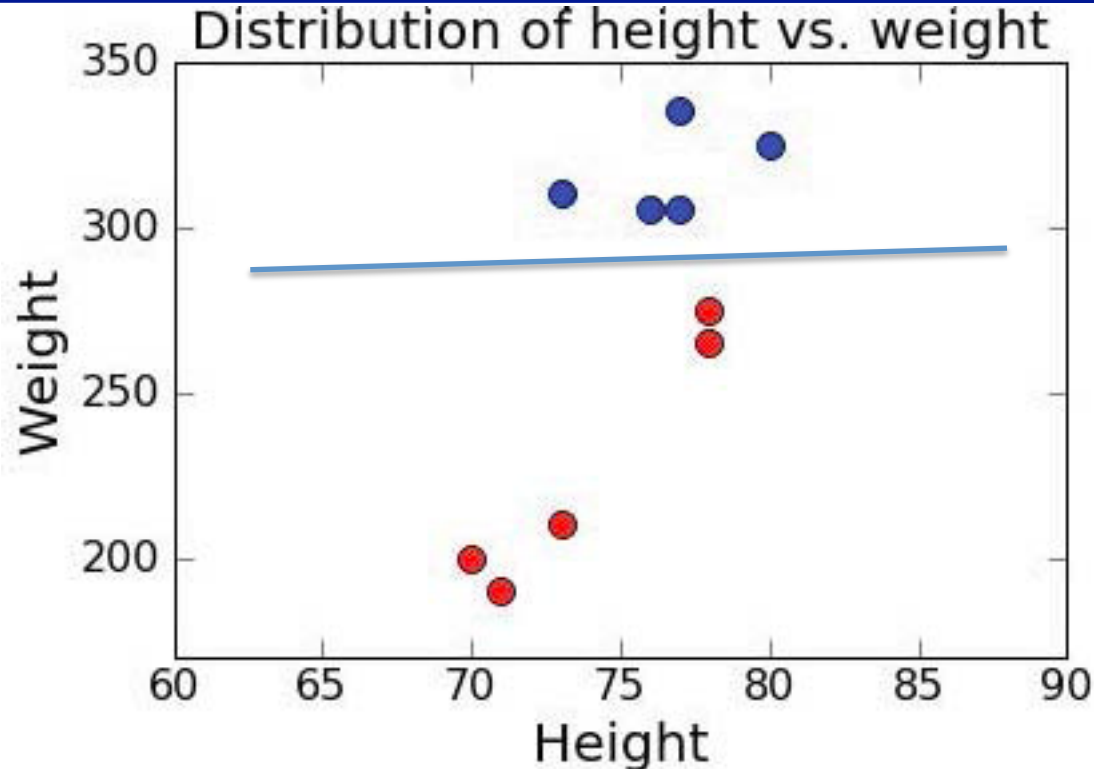
Supervised Learning: Classification



Adapted from source:6-0002-Introduction to Machine Learning by Eric Grimson



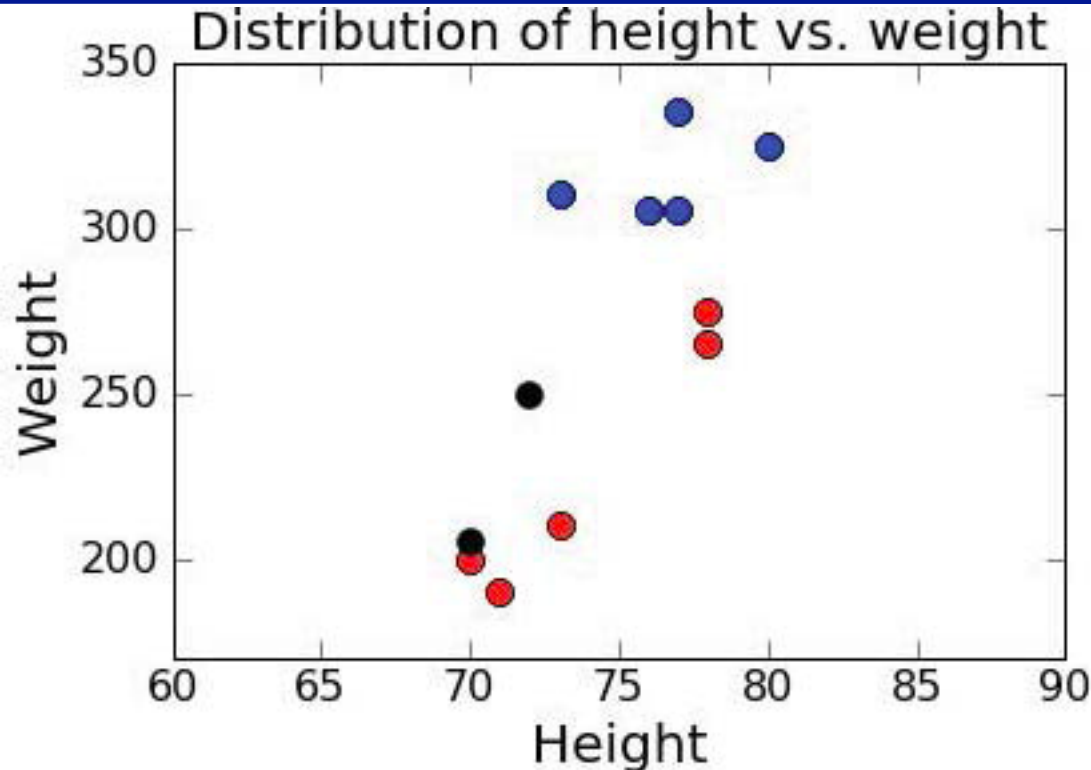
Supervised Learning: Classification



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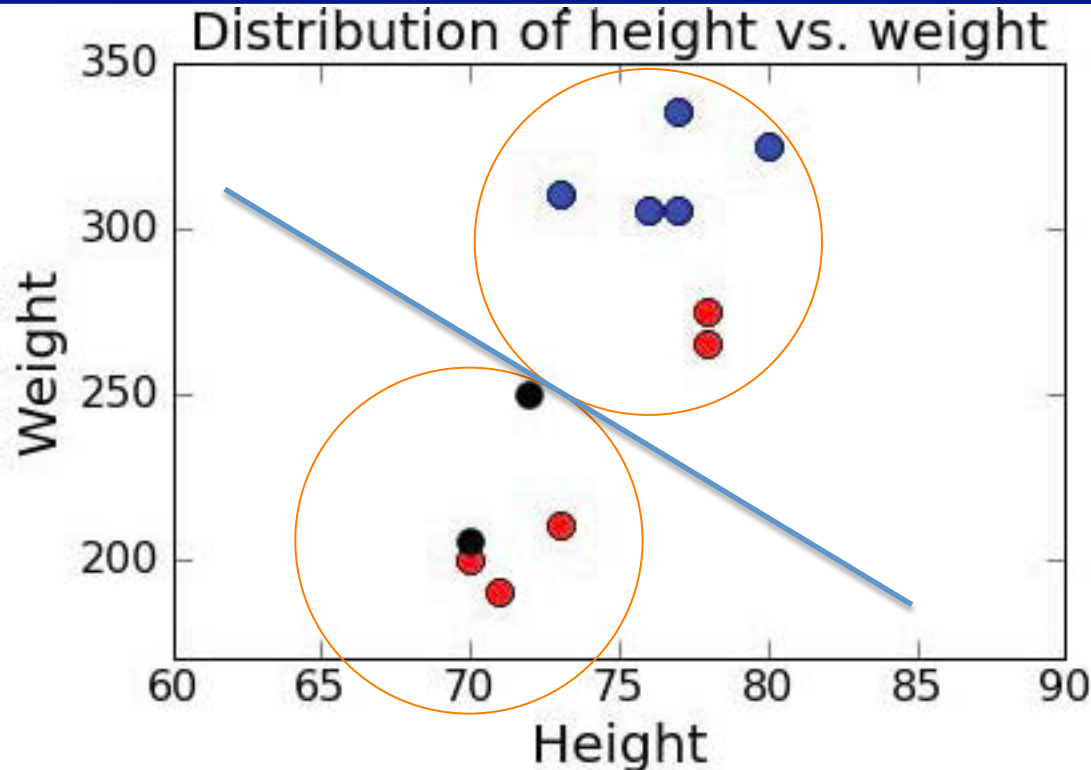
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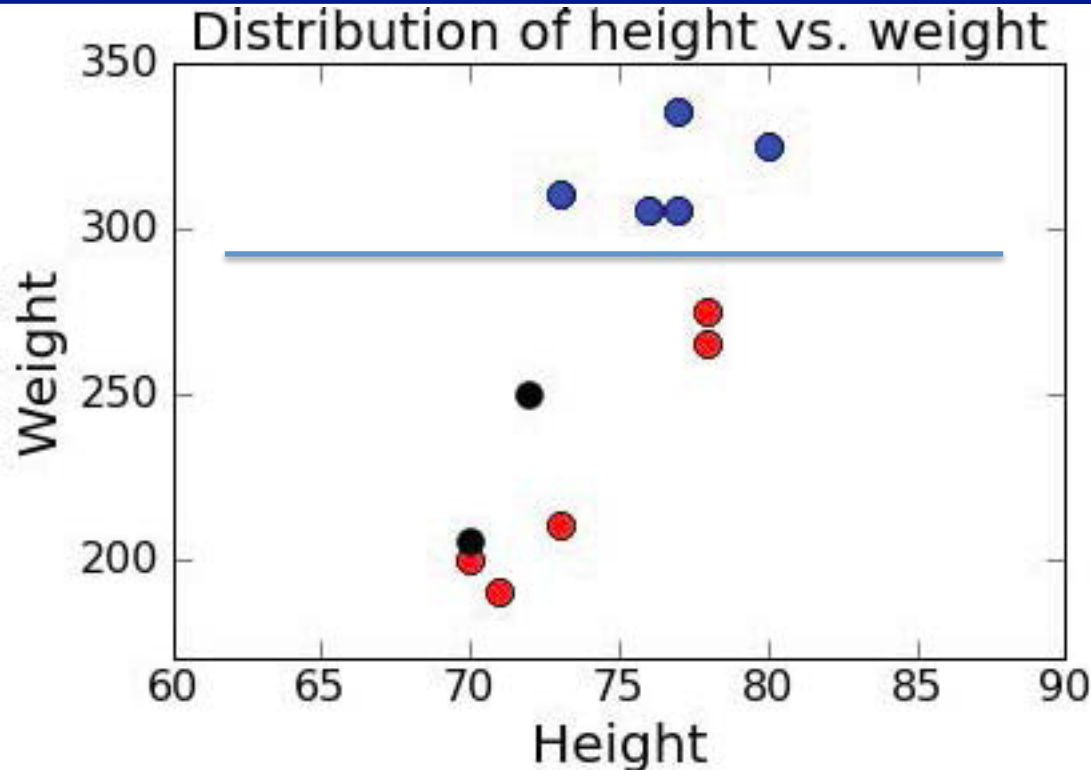
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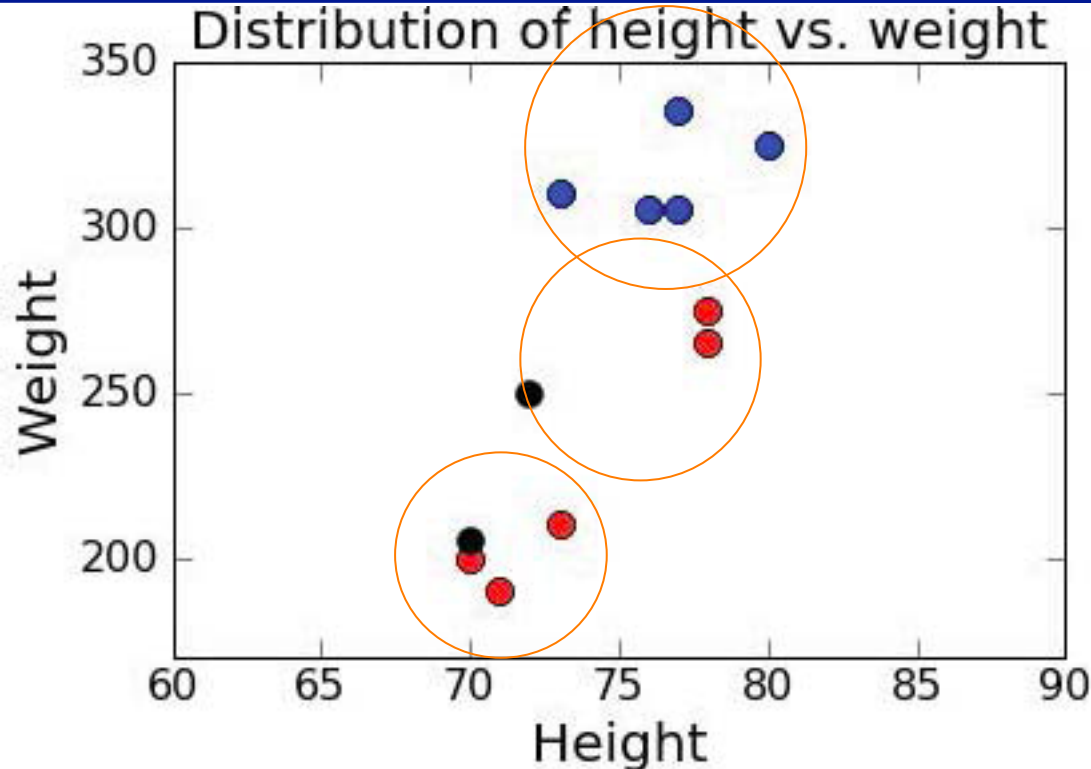
Supervised Learning: Classification



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Supervised Learning: Classification

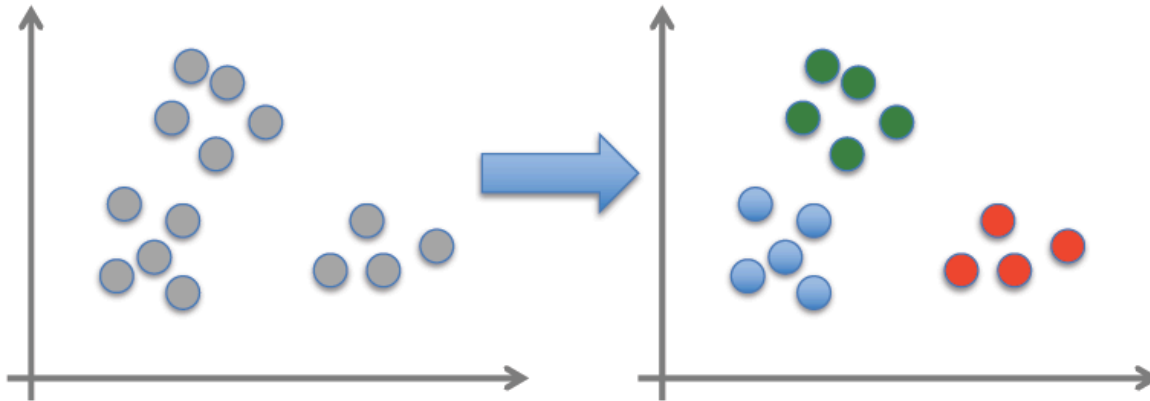


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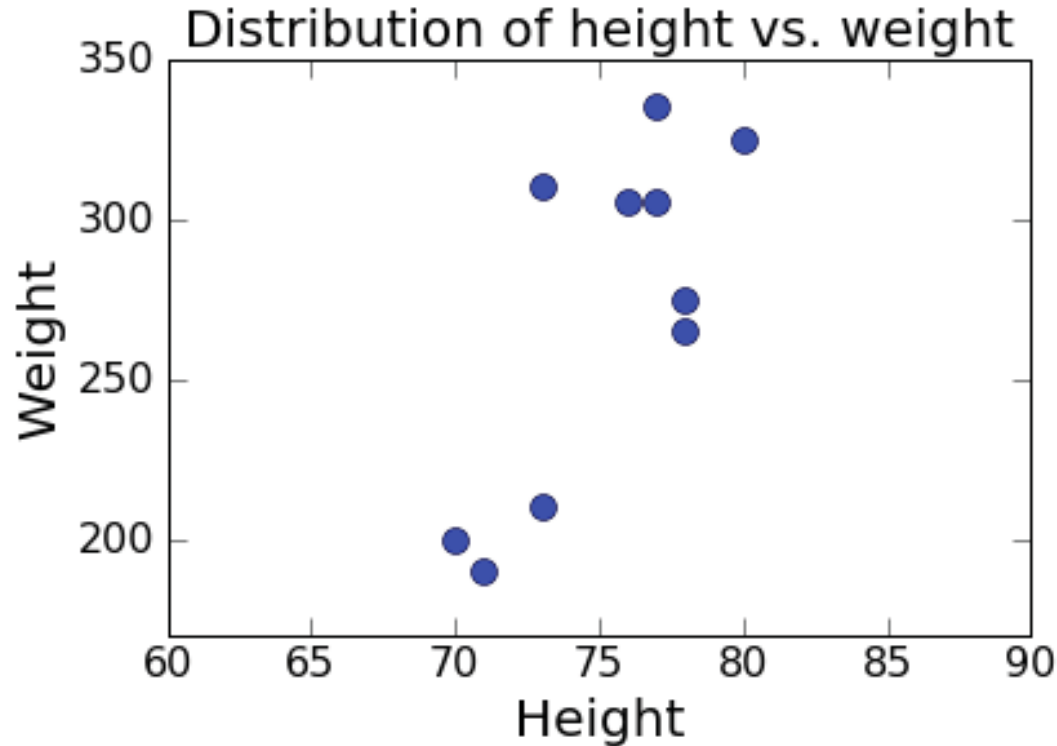
Unlabeled Data

- Given x_1, x_2, \dots, x_n (without labels)
- Output hidden structure behind the x 's
 - E.g., clustering





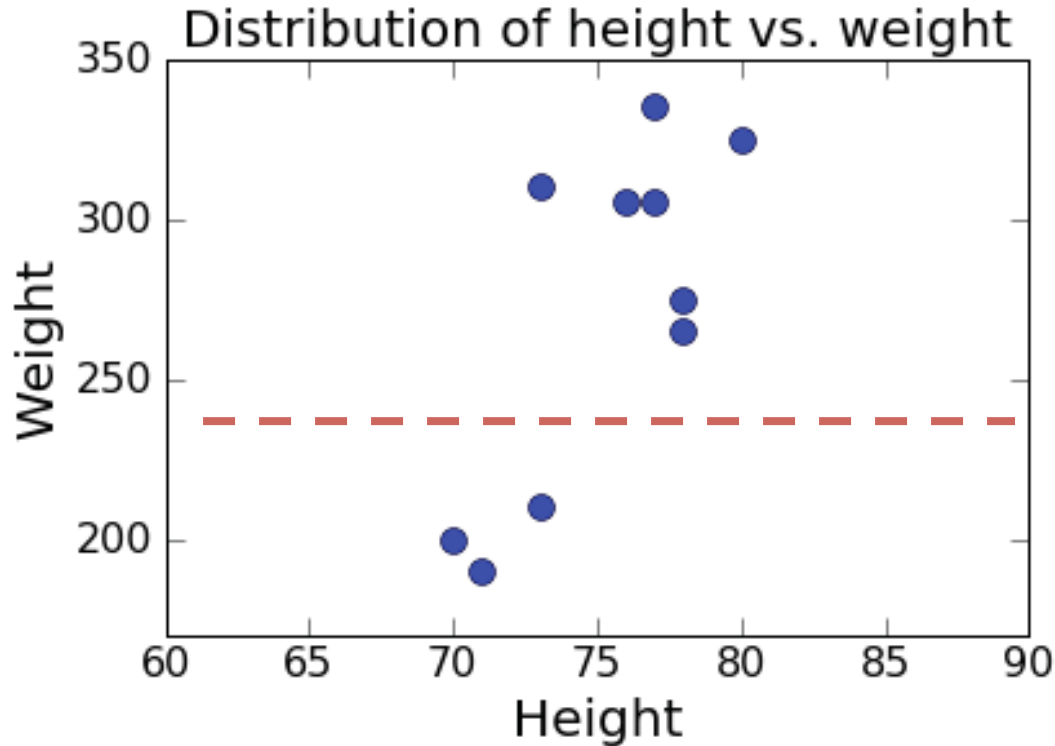
Unlabeled Data



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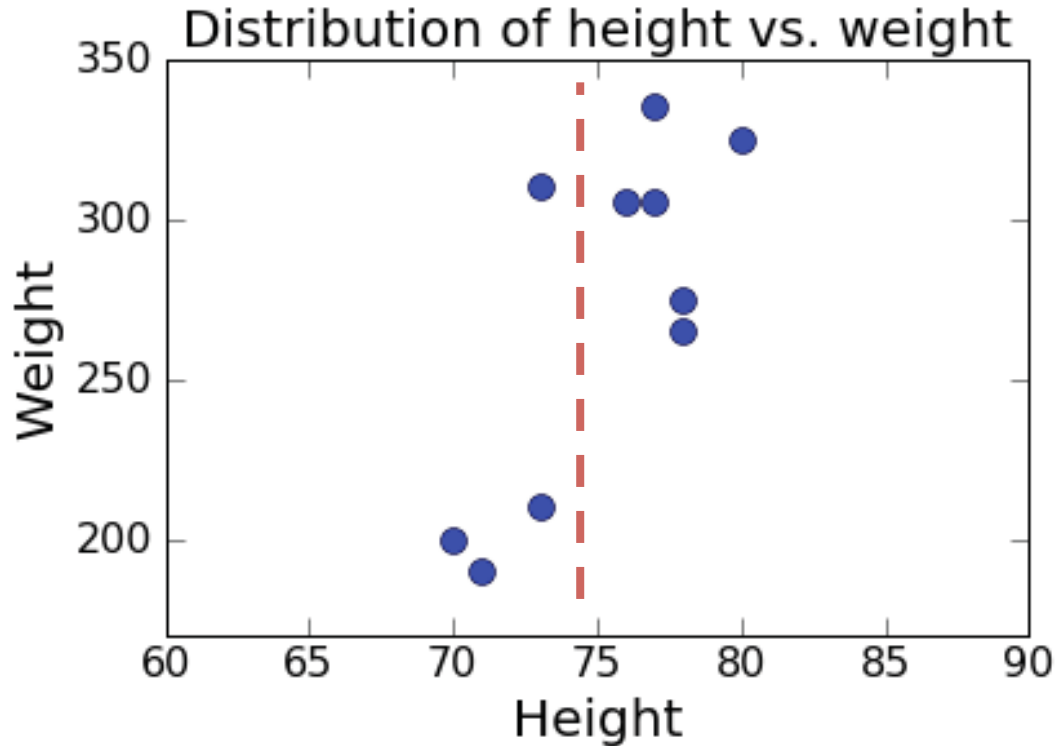
Unlabeled Data



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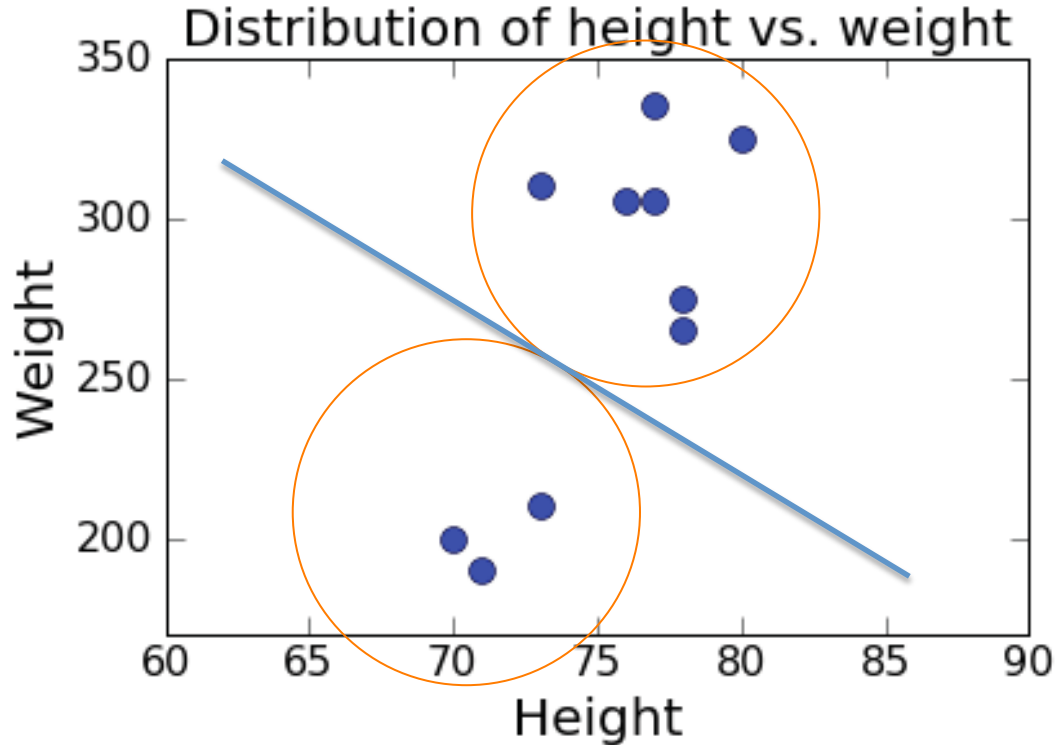
Unlabeled Data



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Unlabeled Data



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Features

- **Feature engineering**
 - Represent examples by feature vectors that will facilitate generalization
 - Suppose I want to use 100 examples from past to predict, at the start of the subject, which students will get an A
 - Some features surely helpful, e.g., GPA, prior programming experience (not a perfect predictor)
 - Others might cause me to overfit, e.g., birth month, eye color
- **Want to maximize ratio of useful input to irrelevant input**
 - Signal-to-Noise Ratio (SNR)



Features

■ Feature engineering:

- Deciding which features to include and which are merely adding noise to classifier
- Defining how to measure distances between training examples (and ultimately between classifiers and new instances)
- Deciding how to weight relative importance of different dimensions of feature vector, which impacts definition of distance



Distance

Minkowski Metric

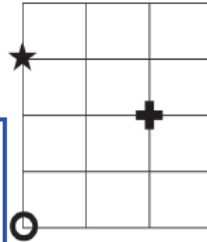
$$dist(X1, X2, p) = \left(\sum_{k=1}^{len} abs(X1_k - X2_k)^p \right)^{1/p}$$

p = 1: Manhattan Distance

p = 2: Euclidean Distance

Need to measure distances between feature vectors

Typically use Euclidean metric; Manhattan may be appropriate if different dimensions are not comparable



Is circle closer to star or cross?

- Euclidean distance
 - Cross – 2.8
 - Star – 3
- Manhattan Distance
 - Cross – 4
 - Star - 3



Confusion Matrix

n=165	Predicted: NO	Predicted: YES
Actual: NO	50	10
Actual: YES	5	100

- There are two possible predicted classes: "yes" and "no". If we were predicting the presence of a disease, for example, "yes" would mean they have the disease, and "no" would mean they don't have the disease.
- The classifier made a total of 165 predictions (e.g., 165 patients were being tested for the presence of that disease).
- Out of those 165 cases, the classifier predicted "yes" 110 times, and "no" 55 times.
- In reality, 105 patients in the sample have the disease, and 60 patients do not.

Adapted from source: <https://www.dataschool.io/simple-guide-to-confusion-matrix-terminology/>



Confusion Matrix

n=165	Predicted: NO	Predicted: YES
Actual: NO	50	10
Actual: YES	5	100

- **true positives (TP):** These are cases in which we predicted yes (they have the disease), and they do have the disease.
- **true negatives (TN):** We predicted no, and they don't have the disease.
- **false positives (FP):** We predicted yes, but they don't actually have the disease. (Also known as a "Type I error.")
- **false negatives (FN):** We predicted no, but they actually do have the disease. (Also known as a "Type II error.")



Accuracy

$$\text{accuracy} = \frac{\text{true positive} + \text{true negative}}{\text{true positive} + \text{true negative} + \text{false positive} + \text{false negative}}$$



Other Measures

$$\text{sensitivity} = \frac{\text{true positive}}{\text{true positive} + \text{false negative}}$$

$$\text{specificity} = \frac{\text{true negative}}{\text{true negative} + \text{false positive}}$$



Minimum Distance Classifier

A Decision Theoretic Approach

Let $x = (x_1, x_2, \dots, x_n)^T$ for W pattern classes $\omega_1, \omega_2, \dots, \omega_W$

$$d_i(x) > d_j(x) \quad j = 1, 2, \dots, W; j \neq i$$

- In other words, an unknown pattern \mathbf{x} is said to belong to the i th pattern class if, upon substitution of \mathbf{x} into all decision functions, $d_i(x)$ yields the largest numerical value.



Minimum Distance Classifier

- Suppose that we define the prototype of each pattern class to be the mean vector of the patterns of that class: $m_j = \frac{1}{N_j} \sum_{x \in \omega_j} x_j \quad j = 1, 2, \dots, W$
- We then assign \mathbf{x} to class ω_i if $D_i(\mathbf{x})$ is the smallest distance. $D_j(x) = \|\mathbf{x} - m_j\|$



Minimum Distance Classifier

$$d_j(x) = x^T m_j - \frac{1}{2} m_j^T m_j \quad j = 1, 2, \dots, W$$

assign \mathbf{x} to class ω_i if $d_i(\mathbf{x})$ is the largest numerical value.

Minimum Distance Classifier

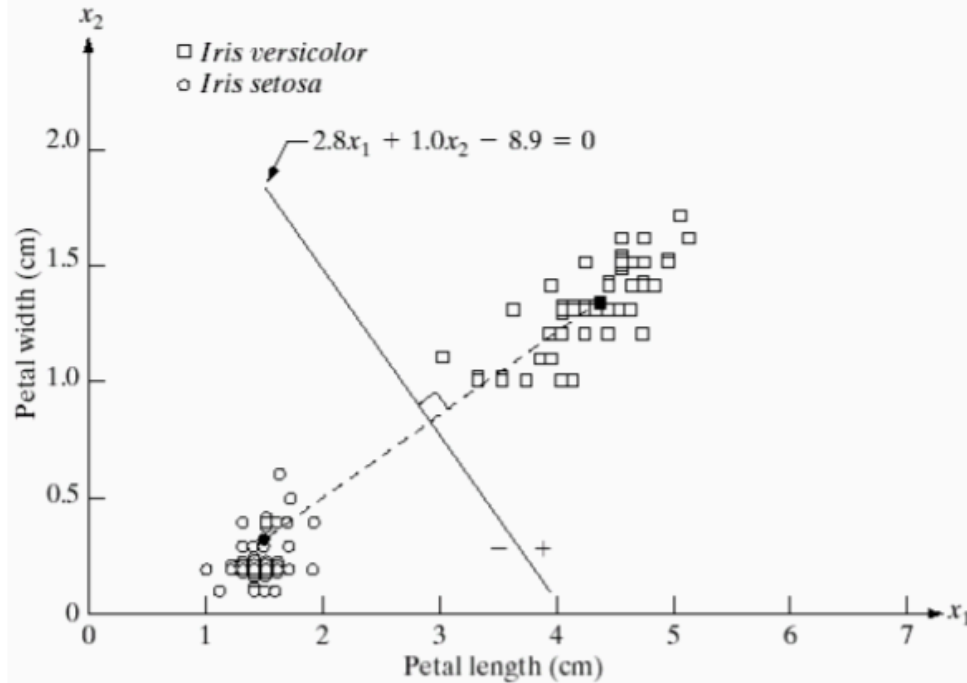


FIGURE 12.6
Decision boundary of minimum distance classifier for the classes of *Iris versicolor* and *Iris setosa*. The dark dot and square are the means.



Home Assignment

Consider two class scenario with 2D features (x_1, x_2) . Is the minimum distance classifier boundary perpendicular to the line joining the two means (prototypes)? Justify your answer.